

Search Notes

Application/Control No.

10/803,536

Examiner

Evan Dzierzynski

Applicant(s)/Patent under
Reexamination

HAYASHI ET AL.

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	465	8/9/2005	ED
	466	8/9/2005	ED
	505	8/9/2005	ED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search strategy from Tom Sember	9/12/2005	ED
STIC search	9/12/2005	ED
Updated search in EAST see attachment	1/11/2006	ED